Thermopower and Hall Effect in silicon nitride composites containing thermally reduced graphene and pure graphene nanosheets

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Abstract
Composites consisting of dielectric silicon nitride (Si₃N₄) with diverse percentages of different graphene nanoreinforcements, such as graphene nanoplatelets (GNP) -17 and 21 vol.%- and reduced graphene oxide (rGO) sheets -4 and 7 vol.%- displayed thermopower effect. Maximum thermopower was observed for the rGO containing composites, which reached a peak Seebeck coefficient (S) of -26 μV.K⁻¹ at 300K, whereas GNP composites showed top S of +5 μV.K⁻¹ at the same temperature. Hall effect measurements indicated that current carriers were different in both composites, electrons for the rGO/Si₃N₄ (n-type conductor) and holes for the GNP/Si₃N₄ materials (p-type conductor) and also having ~1.4 times higher carrier concentration the first composites. The enhanced thermopower of the rGO/Si₃N₄ composites is attributed to the particular defective nature of rGO sheets, which presented edge defects and nanometer scale defect clusters as shown by the high
resolution images – probably associated to both oxygen atoms remaining after GO reduction during spark plasma sintering and N doping from the Si₃N₄ matrix.

1. **Introduction**

One of the routes to create new thermoelectric materials consist in nanostructuring, hence reducing thermal conductivity through phonon scattering, while maintaining a high electrical conductivity [1,2]. The sintering of nanopowders is an alternative route for reducing thermal conductivity by creating multiple interfaces, which also offers the opportunity of improving the poor mechanical properties of most thermoelectric materials [3].

The performance of a thermoelectric material is accounted by the dimensionless figure of merit ZT, defined as $S^2\sigma T/\kappa$, where $S$ is the Seebeck coefficient, $\sigma$ the electrical conductivity, $\kappa$ the thermal conductivity and $T$ the absolute temperature. The upper ZT value for commercial thermoelectric materials stays ~1 and most works in the field aim at raising this value, which is not trivial as the parameters involved are mutually dependent [1].

The single layer graphene (SLG) exhibits high electrical conductivity and high carrier mobility [4] in addition to thermopower effect, with reported peak $S$ values in the range 50-80 $\mu$V.K⁻¹ at 300 K [5,6], which gives large power factors –defined as $PF= S^2\sigma$-- for this material. However, the thermal conductivity of SLG (~ 4000 W.m⁻¹K⁻¹) [7] should be significantly reduced for practical thermoelectric applications [8]. In fact, ZT values for pristine graphene are in the range 0.1-0.01 [9], far from the target value of 1.
Xiao et al. [10] confirmed a substantial increase of the high temperature Seebeck coefficient up to 700 $\mu$V.K$^{-1}$–reaching a maximum power factor of 4.5 mW. m$^{-1}$K$^{-2}$ at 575K– when they treated few layer graphene (FLG) films under an oxygen plasma. Authors explained this enhancement by an effective opening of the electronic band-gap [11] through the generation of disordered carbon spots instead to the presence of oxygen functional groups. They supported this assumption on the much smaller PF, between 0.8-3.6 $\mu$W.m$^{-1}$.K$^{-2}$, they observed for 2nm thick films of reduced with hydrazine with maximum S of +15 $\mu$V.K$^{-1}$ at 300K and upper limit $\sigma$ of 8x$10^{3}$ S.m$^{-1}$ at 525K.

Recent studies [11] on GO paper of around 100 $\mu$m of thickness, with variable grades of chemical reduction, showed S values in the range 10-60 $\mu$V.K$^{-1}$ at room temperature that increased with the amount of oxygen in the specimens. Thus, the maximum thermopower corresponded to the more oxidized specimen that consequently showed the minimum $\sigma$ ~0.1 S.m$^{-1}$. Diminishing the amount of oxygen augmented very effectively $\sigma$ but at the expenses of a lower S. Accordingly, the highest PF (~0.11$\mu$W.m$^{-1}$.K$^{-2}$) was achieved for the more reduced specimens which showed a S of +10 $\mu$V.K$^{-1}$ –being both data close to the values reported above for rGO films– and therefore they could be taken as representative of chemically top reduced GO.

On the other hand, theoretical calculations predict important increases in S coefficient by methods like nanopatterning of the graphene surface for example by chemical functionalization [9], which basically increases the density of states near the band edge.
It is known that graphene fillers can render electrical conductivity to originally insulator matrices, polymers [12] as well as ceramics [13]. Hence, seems coherent to investigate if something similar occurs with the thermoelectric effect in composites containing graphene in concentrations above the percolation limit to assure a contacted graphene network. In this respect, studies on the thermoelectric properties of composites with graphene fillers are scarce. Particularly, we can mention the works on polyaniline with 50 wt.% graphene nanoplatelets (GNPs) and polyaniline with 30 wt.% graphite oxide (GO) flakes, which gave values of the thermoelectric power at room temperature [14,15] between 33-40 \( \mu \text{V}. \text{K}^{-1} \) (power factor, \( \sim 5.6-10 \ \mu \text{W.m}^{-1}.\text{K}^{-2} \)) and \( \sim 25 \ \mu \text{V.K}^{-1} \) (power factor \( \sim 0.4 \ \mu \text{W.m}^{-1}.\text{K}^{-2} \)), respectively.

Focusing on graphene/ceramic materials, we can point out the work [16] on tetragonal zirconia ceramics (3Y-TZP) with 2.65 wt.% of GO –partially reduced during sintering– giving \( S \sim -15 \ \mu \text{V.K}^{-1} \) and power factor of 0.12 \( \mu \text{W.m}^{-1}.\text{K}^{-2} \) at 300K. As antecedent we could mention the work by Zhan et al [17] on 3Y-TZP with single wall carbon nanotubes (SWCNT) that reported a maximum \( S \) of \( \sim 30 \ \mu \text{V}. \text{K}^{-1} \) at 350K and PF around 3 \( \mu \text{W.m}^{-1}.\text{K}^{-2} \) at 350K for the 10 vol. % of SWCNT composite. If we include genuine thermoelectric materials in the scope of ceramic composites, there is also a recent publication [18] on a high temperature thermoelectric ceramic hybrid such as Al-doped ZnO with 1.5 wt.% of chemically reduced GO that stated a decrease of \( S \), in absolute value, at 1173K from 200 to below 100 \( \mu \text{V}. \text{K}^{-1} \) with the rGO addition, although an 60% increase in \( ZT \) (0.28) was measured due to the induced increase of \( \sigma \) and the reduction in \( \kappa \). Similarly, in the case of a Lanthanum Strontium Titanium Oxide
Thermoelectrics a decrease of S coefficient is also reported for GO additions — from 400 to 100 μV. K⁻¹ — with a relatively high power factor (~2500 μWm⁻¹ K⁻²) and figure of merit (ZT = 0.42) at room temperature, also because of the reduction in k and the improvement of σ [19].

It has been shown that graphene/Si₃N₄ composites are remarkable composites regarding toughness and strength properties [20-21], have outstanding electrical conductivity [22] and also produce a decline of the thermal conductivity depending on the crystallinity and the orientation of the graphene stacks [22-24]. In this paper we report for the first time the occurrence of thermoelectric effect for these composites, probing not only various volume concentrations but also two sorts of fillers (thermally reduced GO and pristine GNPs differing in the number of defects and degree of exfoliation). In this way, we determine the impact of the graphene characteristics on the Seebeck coefficient from 100 K to room temperature. The carrier type and concentration are also determined by measurement of the Hall effect for both composite types. As we are dealing with an electrically insulating matrix, the difference observed in the thermoelectric behavior allows without ambiguity its ascription to the particular characteristics of the graphene fillers.

2. Experimental Procedure

Two kinds of ceramic composites were prepared using GNPs and GO sheets, respectively, following the same route described elsewhere [22,25]. In short, the matrix composition was a blend of α-Si₃N₄ (E-10, Ube Corp.) plus 2 wt.% Al₂O₃ (Baikalox-SM8) and 5 wt.% Y₂O₃ (HC-Stark) powders, these oxides acting as sintering aids. GNPs are commercial nanoplatelets (N002 from Angstron
Materials) of nominally 0.2 µm diameter and 1 nm thickness. The nanoplatelets were highly agglomerated in the as received state; accordingly they were dispersed in isopropyl alcohol using a sonication bath before mixing them with the dispersion of the ceramic powders also in same alcohol media. GO sheets, prepared by the modified Hummers method, were re-dispersed in ethanol and blended with the matrix by sonication and blade mixing. The different alcohol media for GNP and GO dispersions was based on stabilization tests. The GNP and GO dispersions were drop cast on glass slides for observation in the scanning force microscope (SFM, Nanotec) for filler thickness evaluations. Densification took place by spark plasma sintering (SPS) (Dr. Sinter, SPS - 510CE) at 1625 °C for 5 min, applying 50 MPa of uniaxial pressure and under vacuum of 4 Pa. Four different specimens –disks of 20 mm diameter and ~3 mm thick- were prepared, two of them with 4 and 7 vol.% of rGO, and the other two having 17 and 21 vol.% of GNPs, respectively. All the composites achieved full densification (>99.7% of theoretical). The dissimilar volume concentrations for GNP and rGO composites are justified by their thickness differences; accordingly, for the thicker fillers, GNPs, a higher volume concentration was needed to achieve an electrically contacted network [22,25].

Field emission scanning electron microscopy (FE-SEM, S-4700 Hitachi, Japan) was used to analyze the microstructure of the specimens. Raman spectra were recorded (WITec spectrometer, Alpha-300) at a laser excitation wavelength of 532 nm. Raman scans of 100 x 100 points and 60 ms acquisition time per spectrum were recorded in polished areas of 10X10 µm². The microstructure at higher resolution of the 4 vol. % rGO composite was observed in a microscope Jeol JEM ARM 200cF with aberration correction of condenser lens able to work
in TEM and STEM (scanning transmission electron microscopy) modes and HAADF (High-angle annular dark-field) conditions. Specimen was prepared by dimple grinding and ion milling methods.

Different thermal gradients were applied with a ceramic resistor attached to the samples (see scheme in Fig. 1) to measure the Seebeck coefficient. The induced temperature difference and thermal voltage were recorded at each base temperature with a difference thermocouple and Cu wires, respectively. The measurements were performed under vacuum between 100 and 325 K.

The carrier density was determined from measurements of the Hall effect in thin square-shaped sections of each sample. The samples were contacted in the corners, in a Van der Paw configuration. Room temperature electrical and thermal conductivities measured in the two types of the specimens were used to compare the PF and ZT of each specimen. The dc electrical conductivity was determined using four-probe and the thermal conductivity was calculated from the thermal diffusivity measured by the laser flash method. In the case of the 7 vol.% rGO and 21 vol. % GNP specimens, the conductivity was appraised using simple thermal resistance models and the conductivities of the matrix and reinforcements. Both properties were determined for the same specimen orientation than stated for the S measurements, i.e. in-plane orientation of the graphene nanostructures and data provided here are the same as those reported in previous works [22,24] for identical specimens.

3. **Results and Discussion**

Microstructure of composites with 17 vol. % GNP and 7 vol % rGO are readily compared in Fig. 2, they basically consist of a fine grained Si₃N₄ matrix with
either GNPs or rGO sheets preferentially aligned (Fig. 2a,c) along the plane perpendicular to the vertical loading axis defined by the SPS consolidation process. As-synthesized GO sheets are thinner than GNPs such as denoted by SFM images of Fig. 2b,e and their corresponding depth profiles; the thickness difference between both graphene fillers is preserved in the consolidated composites. Consequently, Si₃N₄ composites with rGO fillers have lower percolation limit for electrical conduction, evidenced by the lower concentration required ~3 vol.% rGO against ~7 vol.% for GNPs to achieve measurable electric conductivity, as it was fully discussed in previous works [22,25].

The higher exfoliation condition of rGO filler compared to GNPs is plainly reflected by the Raman images constructed by filtering the intensity ratio of the 2D (~2700 cm⁻¹) and G (~1580 cm⁻¹) characteristic Raman bands of graphene, I₂D/I₆, for each composite type, depicted particularly for the 21 vol. % GNP and 7 vol. % rGO composites in Fig. 3a,d. Actually, the occurrence of brighter zones of high intensity ratios (I₂D/I₆ >0.6) typical of FLG is more frequent for the rGO composite. Singular spectra with I₂D/I₆ >1 (Fig. 3 b,e) distinctive of single layer graphene [26] are also more frequent in the last material. The D peak in the Raman spectra appearing near 1355 cm⁻¹ and reflecting the existence of defects is more intense in rGO composites as shown by the average Raman spectra (Fig. 3c,f), with an intensity ratio of the defects D band to the G band, I_D/I_G, of 0.42 as compared to I_D/I_G of 0.22 for GNP composites. The more intense D band of rGO specimens is due to the existence of different functional groups not completely eliminated after the GO thermal reduction during the SPS of the composites. In fact, as stated in a previous work [25] the percentage of C–C and C=C bonds in the rGO structure reached ~80.4%, the rest
corresponding to epoxy and hydroxyl bonds [27] although the presence of C-N bond cannot be discarded as it has similar binding energy as the C-OH bond [25]. The high intensity of the G band and the sharpness of the Raman peaks in the rGO composites compared to spectra normally observed for rGO obtained by chemical and/or more conventional thermal reduction [27] at temperatures below 1100 °C can be attributed to the drastic experimental conditions of the SPS [28].

The low voltage atomic resolution images in STEM mode of the Si$_3$N$_4$ with 4 vol. % rGO composite (Fig. 4a) allows identifying the different phases according to the attached fast Fourier transforms (FFT). The thin rGO sheets, the Si$_3$N$_4$ grain and the triple point (TP) amorphous phase, consistent with the liquid phase sintering process. The rGO sheets observed are FLG (4-10 layers), with a distance between atomic planes of 0.3 nm and with a certain degree of misorientation between the graphene planes (FFT in Fig. 4b). Closer examination of the large rGO film projecting from the interface with the Si$_3$N$_4$ grain permits identification of typical defective zones at the edges of the rGO sheet, residues from the reduction process [27], but we can detect as well nano-clusters (2-5 nm) of disordered/defective zones on the graphene plane (Fig. 4b) separated by less than 5 nm. This picture is consistent with the structural models representing the reduction process in GO films, in which initial large zones having O bonds are reduced and isolated while sp$^2$ C bonds are progressively reconstructed. Actually, the high temperature SPS process allows a high degree of crystalline reconstruction of the graphene network in GO [29].

The temperature dependence of the thermoelectric power of rGO/Si$_3$N$_4$ and GNP/Si$_3$N$_4$ composites are shown in Figure 5. Different signs of S are observed
for rGO (-) and GNP (+) composites for the whole temperature range (100-320 K), showing both composites an increase in the absolute values of S with temperature and a peak S value of -25 µV/K at 320 K corresponding to the Si₃N₄-4 vol.% rGO composite, ~4 times higher than maximum S for GNP composites (Fig. 5, Table 1).

The room temperature S values of the GNP composites, +5 and +3.7 µV.K⁻¹ (see Table 1) are within the range of values reported for flexible graphite paper, from -2.6 and to +12 µV.K⁻¹ at ~300K [30-32], made by compressing exfoliated graphite flakes from expanded graphite—no data for ceramic composites with pristine GNP are available to compare. The S values for rGO/Si₃N₄ composites, -26 and -24 µV.K⁻¹, are relatively higher in absolute value than published data for various GO/Y-TZP composites [16,33] (-15, +17 and +22 µV.K⁻¹ at 300K) and for FLG/Al₂O₃ composite [33] (-17 µV.K⁻¹ at 300K), all reduced during sintering. Present values are also above the S (+10 µV.K⁻¹) of rGO films above reported [11].

Given the linear temperature dependence of the thermopower in the composites (Fig. 5) and considering the sign of S, we can assume that electric carriers are electrons for rGO composites and holes for the GNP types. The Hall effect measurement confirm these terms, see as example the result for the 4 vol.% rGO composite in Fig. 6. The corresponding carrier concentration gives values of 6.3 x10¹⁹ e/cm³ of hole carriers for Si₃N₄-17 vol.% GNP composite (p-type), and 8.6 x10¹⁹ e/cm³ of electron carriers for the Si₃N₄-4 vol.% rGO composite (n-type). Accordingly, the sign of the Seebeck coefficient in these composites is effectively determined by the carrier sign. Therefore, the higher S absolute
values observed for rGO composites are not linked to a decrease in the carrier concentration, and then it has to be linked to other effects such as possible changes in the density of electronic states (DOS) near the Fermi level [16]. This effect can be attributed to oxygen functionalities or even some N doping of the graphene network and associated to the defective nanoclusters observed in the rGO sheet (Fig. 4), thus creating structural disorder and opening the band gap [1,34]. The possible N doping would be supported as well by the n-type character often reported for N-doped graphene monolayer [35].

PF for the different volume fractions were estimated at room temperature as shown in Table 2. The highest PF (0.38 $\mu$W.m$^{-1}$.K$^{-2}$) is observed for the Si$_3$N$_4$-7 vol.% rGO composite, around 6 times higher than composite with 4 vol.% rGO, essentially due to its greater electrical conductivity (see Table 2). Comparing with GNP composites, increases of 17 times in the PF are observed, and as good as values reported for polyaniline (0.4-10) [14-15] and 3Y-TZP (0.12) [16] with GO fillers. The composite with top PF also has the highest ZT value ($0.09\times10^{-4}$) although far from optimal (ZT $\geq$1) for practical uses.

Hence, thermoelectric characteristics of silicon nitride composites with rGO fillers are more relevant than those with GNPs as the lower $\sigma$ is compensated by the higher S and relatively lower $\kappa$ (Table 2). Reduction of GO fillers during the high temperature SPS process is effective for increasing the thermopower characteristics due to nanoclustering of defects (oxygen groups and N doping). Interestingly p- and n- doping are achieved in graphene/Si$_3$N$_4$ just by changing the type of graphene filler. Although these composites might not be competitive
for practical uses, present findings are interesting starting point for further developments.

4. Conclusions

We demonstrated that graphene-Si₃N₄ composites consolidated by SPS possess novel thermoelectric effect with different characteristics for thermally reduced graphene oxide and pristine graphene nanoplatelets. A peak thermopower of -26 µV.K⁻¹ at room temperature is achieved for the Si₃N₄-4 vol.% rGO composite, whereas a top S of +5 µV.K⁻¹ is reached for the Si₃N₄-17 vol.% GNP material. The rGO composites are n-type semiconductors and have electrons as the main current carrier whereas GNP composites are p-type with holes as native carriers. Carrier concentrations are in the order of 10¹⁹ e/cm³ for both composites and slightly higher for rGO composites, hence are not the cause of the differences in S. The comparatively higher thermoelectric power for rGO composites is attributed to the presence of defective nano-clusters in the graphene plane observed by STEM, linked to O/N functionalities that would affect the densities of states at the bandgap. The higher S of rGO composites is also accompanied by a larger PF (0.38 µW.m⁻¹.K⁻²) and ZT number.

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Table 1. Thermoelectric power at room temperature for different composites

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<thead>
<tr>
<th>sample</th>
<th>S (µV/K) at 300 K</th>
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<tbody>
<tr>
<td>Si$_3$N$_4$- 4 vol % rGO</td>
<td>-25</td>
</tr>
<tr>
<td>Si$_3$N$_4$- 7 vol % rGO</td>
<td>-23.6</td>
</tr>
<tr>
<td>Si$_3$N$_4$- 17 vol % GNP</td>
<td>5.0</td>
</tr>
<tr>
<td>Si$_3$N$_4$- 21 vol % GNP</td>
<td>3.7</td>
</tr>
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</table>
Table 2. Thermal conductivity ($\kappa$), electrical conductivity ($\sigma$), power factor (PF) and figure of merit (ZT) for the different composites at 300K.

<table>
<thead>
<tr>
<th>Sample</th>
<th>$\kappa^{22}$ (W.m(^{-1}).K(^{-1}))</th>
<th>$\sigma^{24}$ (S.m(^{-1}))</th>
<th>PF (µW.m(^{-1}).K(^{-2}))</th>
<th>ZT x 10(^{-4})</th>
</tr>
</thead>
<tbody>
<tr>
<td>Si(_3)N(_4)-4 vol.% rGO</td>
<td>14.8</td>
<td>90</td>
<td>0.06</td>
<td>0.012</td>
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<tr>
<td>Si(_3)N(_4)-7 vol.% rGO</td>
<td>12.3</td>
<td>690</td>
<td>0.38</td>
<td>0.09</td>
</tr>
<tr>
<td>Si(_3)N(_4)-17 vol.% GNP</td>
<td>38.5</td>
<td>908</td>
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<td>0.002</td>
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<tr>
<td>Si(_3)N(_4)-21 vol.% GNP</td>
<td>44.0</td>
<td>2020</td>
<td>0.027</td>
<td>0.002</td>
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</table>
References


Figure Captions

Figure 1. Schematic of experimental setting for Seebeck measurement
Figure 2. Panel showing representative microstructures of the composites and the GRMs. (a) Fracture surface GNP composite (17 vol.%) where graphene nanostructures are identified protruding from the surface and with a preferential horizontal orientation, (b) SFM image of original GNPs dispersed and corresponding depth profile, (c) fracture surface rGO composite (7 vol.%) with undulating and oriented rGO sheets (d) SFM image of as-synthesized with dispersed GO and corresponding depth profile.
Figure 3. (a) Raman image constructed by filtering the 2D graphene signal normalized by the intensity of the G band, i.e. mapping of $I_{2D}/I_G$ signal with scale variation from 0.2 to >0.6 for the Si$_3$N$_4$/21 vol. % GNP composite, (b) single spectra of intense spot circled in (a) image, (c) average spectra of the whole area in (a) image, (d) same construction as in (a) for Si$_3$N$_4$/7 vol. % rGO composite, (d) single spectra of intense spot circled in (d) image, (e) average spectra of the whole area in (d) image.
Figure 4. (a) STEM image of 7 vol. % rGO composite showing the ab graphene plane of a rGO sheet, Si$_3$N$_4$ grain and amorphous triple point with corresponding local FFT. (b) Details of rGO sheet. Above: Disordered defective regions (1) are observed at the edge of the rGO sheet and also on the ab plane, appearing encircled in the image. Below: Magnification of the edge (2) showing that rGO sheet is a stack of 4 layers rotated with respect to each other (FFT).
Figure 5. Low temperature Seebeck coefficient for Si₃N₄ composites with 17 vol. % of GNP's and 4 vol. % rGO.

Figure 6. I/V curve of the 4.3 vol.% composite measured in Van der Paw configuration. The inset shows the Hall resistance as a function of the magnetic field.